## Search Notes



U.S. Patent and Trademark Office

Application/Control No.	

lo. Applicant(s)/Patent Under Reexamination
NISHIO ET AL.

10567657

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Examiner

Art Unit

HENOK LEGESSE

2861

## SEARCHED

Class	Subclass	Date	Examiner		
347	55,73-83	07/13/2010	HL		
118	621,624	07/13/2010	HL		
239	690,706	07/13/2010	HL		

## SEARCH NOTES

Search Notes	Date	Examiner
IDS 06/05/2006 and 02/08/2006 considered	07/13/2010	HL
Text searches in class 347 ,118,239 and EAST	07/13/2010	HL
Inventor's name search	07/13/2010	HL

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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